

MOSFET – P-Channel, POWERTRENCH[®] -100 V, -15 A, 67 m Ω

FDMC86139P

General Description

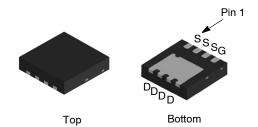
This P-Channel MOSFET is produced using **onsemi's** advanced POWERTRENCH technology. This very high density process is especially tailored to minimize on-state resistance and optimized for superior switching performance.

Features

- Max $r_{DS(on)} = 67 \text{ m}\Omega$ at $V_{GS} = -10 \text{ V}$, $I_D = -4.4 \text{ A}$
- Max $r_{DS(on)} = 89 \text{ m}\Omega$ at $V_{GS} = -6 \text{ V}$, $I_D = -3.6 \text{ A}$
- Very Low RDS-On Mid Voltage P Channel Silicon Technology Optimised for Low Qg
- This Product is Optimised for Fast Switching Applications as well as Load Switch Applications
- 100% UIL Tested
- These Devices are Pb-Free and are RoHS Compliant

Applications

- Active Clamp Switch
- Load Switch



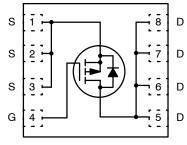
WDFN8 3.3x3.3, 0.65P CASE 511DH

MARKING DIAGRAM

FDMC 86139P &Z&K&2

FDMC = Specific Device Code 86139P = Specific Device Code &Z = Assembly Location &K = Lot Run Traceability Code &2 = Date Code (Year and Week)

PIN ASSIGNMENT



P-Channel MOSFET

ORDERING INFORMATION

See detailed ordering and shipping information on page 6 of this data sheet.

MOSFET MAXIMUM RATINGS ($T_A = 25^{\circ}C$ unless otherwise noted)

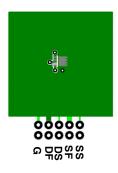
Symbol	Parameter			Rating	Unit
V _{DS}	Drain to Source Voltage		100	V	
V_{GS}	Gate to Source Voltage		±25	V	
I _D	Drain Current	Continuous	T _C = 25°C	-15	Α
		Continuous (Note 1a)	T _A = 25°C	-4.4	
		Pulsed		-30	
E _{AS}	Single Pulse Avalanche Energy (Note 3)	9 3)		121	mJ
P_{D}	Power Dissipation	ation $T_C = 25^{\circ}C$		40	W
	Power Dissipation (Note 1a)		T _A = 25°C	2.3	
T_J , T_{STG}	Operating and Storage Junction Temper	ature Range		-55 to + 150	°C

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

THERMAL CHARACTERISTICS

Symbol	Parameter	Rating	Unit
Rejc	Thermal Resistance, Junction to Case	3.1	°C/W
RθJA	Thermal Resistance, Junction to Ambient (Note 1a)	53	

^{1.} $R_{\theta JA}$ is determined with the device mounted on a 1 in² pad 2 oz copper pad on a 1.5 x 1.5 in. board of FR-4 material. $R_{\theta JC}$ is guaranteed by design while $R_{\theta CA}$ is determined by the user's board design.



a. 53°C/W when mounted on a 1 in² pad of 2 oz copper



b. 125°C/W when mounted on a minimum pad of 2 oz copper

- 2. Pulse Test: Pulse Width < 300 μ s, Duty cycle < 2.0%. 3. Starting T_J = 25°C; P-ch: L = 3 mH, I_{AS} = -9 A, V_{DD} = -100 V, V_{GS} = -10 V. 100% test al L = 0.1 mH, I_{AS} = -28 A

ELECTRICAL CHARACTERISTICS ($T_J = 25^{\circ}C$ unless otherwise noted)

Symbol	Parameter	Test Conditions	Min	Тур	Max	Unit
FF CHAR	ACTERISTICS					
BV _{DSS}	Drain to Source Breakdown Voltage	$I_D = -250 \mu A, V_{GS} = 0 V$	-100	-	-	V
$\frac{\Delta BV_{DSS}}{\Delta T_{J}}$	Breakdown Voltage Temperature Coefficient	$I_D = -250 \mu A$, referenced to 25°C	-	-63	-	mV/°C
I _{DSS}	Zero Gate Voltage Drain Current	V _{DS} = -80 V, V _{GS} = 0 V	-	-	-1	μΑ
I _{GSS}	Gate to Source Leakage Current	V _{GS} = ±25 V, V _{DS} = 0 V	-	-	±100	nA
N CHARA	CTERISTICS					
V _{GS(th)}	Gate to Source Threshold Voltage	$V_{GS} = V_{DS}, I_D = -250 \mu A$	-2	-3	-4	V
$\frac{\Delta V_{GS(th)}}{\Delta T_J}$	Gate to Source Threshold Voltage Temperature Coefficient	$I_D = -250 \mu A$, referenced to 25°C	-	7	_	mV/°C
r _{DS(on)}	Static Drain to Source	V _{GS} = -10 V, I _D = -4.4 A	-	56	67	mΩ
` ,	On Resistance	V _{GS} = -6 V, I _D = -3.6 A	-	69	69 89	
		V _{GS} = -10 V, I _D = -4.4 A, T _J = 125°C	-	87	104	
9FS	Forward Transconductance	V _{DS} = -10 V, I _D = -4.4 A	-	12	_	S
YNAMIC C	CHARACTERISTICS	•				
C _{iss}	Input Capacitance	$V_{DS} = -50 \text{ V}, V_{GS} = 0 \text{ V}, f = 1 \text{ MHz}$	-	1001	1335	pF
C _{oss}	Output Capacitance	1	-	178	240	pF
C _{rss}	Reverse Transfer Capacitance	1	-	10	15	pF
Rg	Gate Resistance		0.1	1.6	3.2	Ω
WITCHING	CHARACTERISTICS					
t _{d(on)}	Turn-On Delay Time	$V_{DD} = -50 \text{ V}, I_D = -4.4 \text{ A}, V_{GS} = -10 \text{ V},$	-	11	20	ns
t _r	Rise Time	$V_{DD} = -50 \text{ V}, I_{D} = -4.4 \text{ A}, V_{GS} = -10 \text{ V},$ $R_{GEN} = 6 \Omega$		2.5	10	ns
t _{d(off)}	Turn-Off Delay Time		-	17	30	ns
t _f	Fall Time		-	4	10	ns
Q _{g(TOT)}	Total Gate Charge	$V_{DD} = -50 \text{ V}, I_D = -4.4 \text{ A}, V_{GS} = 0 \text{ V to } -10 \text{ V}$	-	16	22	nC
		$V_{DD} = -50 \text{ V}, I_D = -4.4 \text{ A}, V_{GS} = 0 \text{ V to } -6 \text{ V}$	-	9.8	14	
Q _{gs}	Total Gate Charge	V _{DD} = -50 V, I _D = -4.4 A	-	4.5	_	nC
Q_{gd}	Gate to Drain "Miller" Charge	1	-	3.2	-	nC
	URCE DIODE CHARACTERISTICS			-	<u>-</u>	-
V _{SD}	Source to Drain Diode Forward	V _{GS} = 0 V, I _S = -4.4 A (Note 2)	-	-0.84	-1.3	٧
	Voltage	V _{GS} = 0 V, I _S = -1.9 A (Note 2)	-	-0.79	-1.2	1
t _{rr}	Reverse Recovery Time	I _F = -4.4 A, di/dt = 100 A/μs	-	70	112	ns
	<u> </u>	╡		 	 	

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

5

TYPICAL CHARACTERISTICS (T_J = 25°C unless otherwise noted)

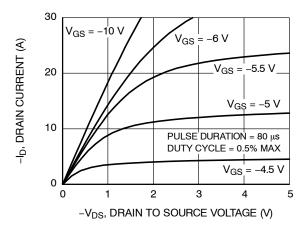


Figure 1. On Region Characteristics

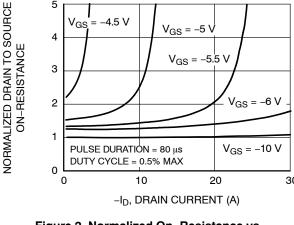


Figure 2. Normalized On-Resistance vs. **Drain Current and Gate Voltage**

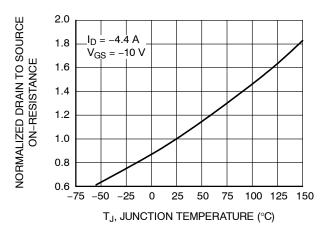


Figure 3. Normalized On Resistance vs. Junction Temperature

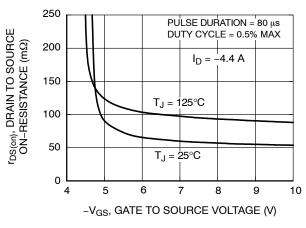


Figure 4. On-Resistance vs. Gate to Source Voltage

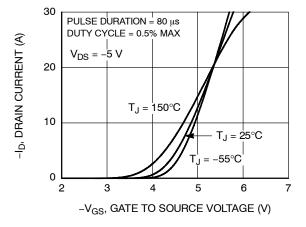


Figure 5. Transfer Characteristics

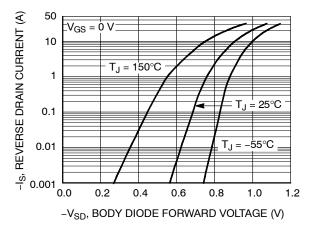


Figure 6. Source to Drain Diode Forward Voltage vs. Source Current

TYPICAL CHARACTERISTICS (T_J = 25°C unless otherwise noted) (continued)

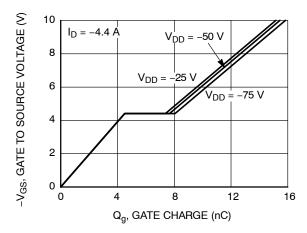


Figure 7. Gate Charge Characteristics

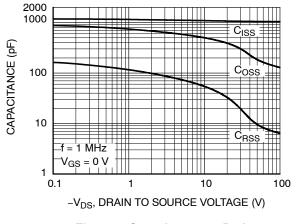


Figure 8. Capacitance vs. Drain to Source Voltage

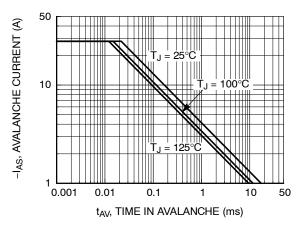


Figure 9. Unclamped Inductive Switching Capability

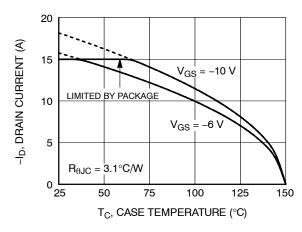


Figure 10. Maximum Continuous Drain Current vs. Case Temperature

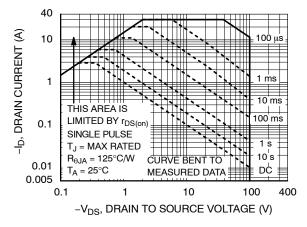


Figure 11. Forward Bias Safe Operating Area

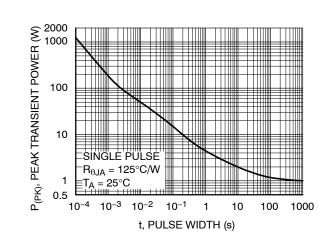


Figure 12. Single Pulse Maximum Power Dissipation

TYPICAL CHARACTERISTICS ($T_J = 25^{\circ}C$ unless otherwise noted) (continued)

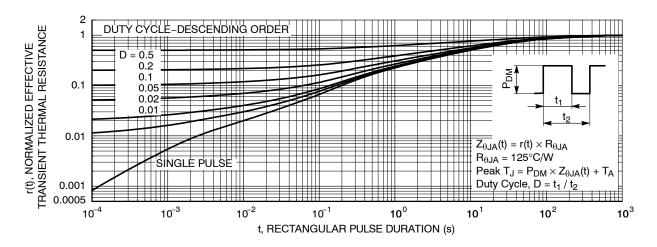


Figure 13. Junction-to-Ambient Transient Thermal Response Curve

ORDERING INFORMATION

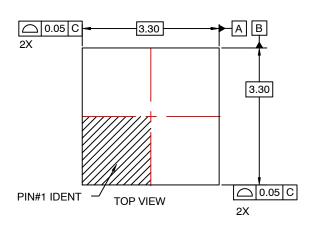
Device	Device Marking	Package Type	Reel Size	Tape Width	Shipping [†]
FDMC86139P	FDMC86139P	WDFN8 3.3x3.3, 0.65P Power 33 (Pb-Free)	13"	12 mm	3000 / Tape & Reel

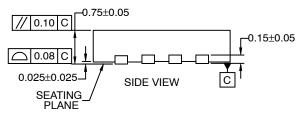
[†]For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

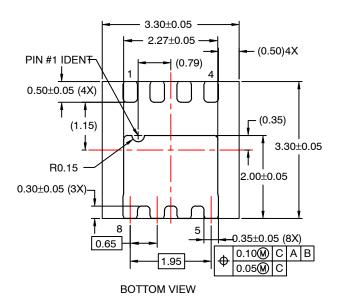
POWERTRENCH is registered trademark of Semiconductor Components Industries, LLC (SCILLC) or its subsidiaries in the United States and/or other countries.

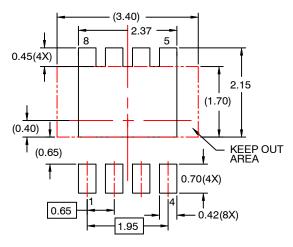
WDFN8 3.3x3.3, 0.65P CASE 511DH ISSUE O

DATE 31 JUL 2016









RECOMMENDED LAND PATTERN

NOTES:

- A. DOES NOT CONFORM TO JEDEC REGISTRATION MO-229
- B. DIMENSIONS ARE IN MILLIMETERS.
- C. DIMENSIONS AND TOLERANCES PER ASME Y14.5M, 2009.
- D. LAND PATTERN RECOMMENDATION IS EXISTING INDUSTRY LAND PATTERN.

DOCUMENT NUMBER: 98AON13625G Electronic versions are uncontrolled except when accessed directly from Printed versions are uncontrolled except when stamped "CONTROLLE"			
DESCRIPTION:	WDFN8 3.3X3.3, 0.65P	•	PAGE 1 OF 1

ON Semiconductor and a retrademarks of Semiconductor Components Industries, LLC dba ON Semiconductor or its subsidiaries in the United States and/or other countries. ON Semiconductor reserves the right to make changes without further notice to any products herein. ON Semiconductor makes no warranty, representation or guarantee regarding the suitability of its products for any particular purpose, nor does ON Semiconductor assume any liability arising out of the application or use of any product or circuit, and specifically disclaims any and all liability, including without limitation special, consequential or incidental damages. ON Semiconductor does not convey any license under its patent rights nor the rights of others.

onsemi, ONSEMI., and other names, marks, and brands are registered and/or common law trademarks of Semiconductor Components Industries, LLC dba "onsemi" or its affiliates and/or subsidiaries in the United States and/or other countries. onsemi owns the rights to a number of patents, trademarks, copyrights, trade secrets, and other intellectual property. A listing of onsemi's product/patent coverage may be accessed at www.onsemi.com/site/pdf/Patent-Marking.pdf. Onsemi reserves the right to make changes at any time to any products or information herein, without notice. The information herein is provided "as-is" and onsemi makes no warranty, representation or guarantee regarding the accuracy of the information, product features, availability, functionality, or suitability of its products for any particular purpose, nor does onsemi assume any liability arising out of the application or use of any product or circuit, and specifically disclaims any and all liability, including without limitation special, consequential or incidental damages. Buyer is responsible for its products and applications using onsemi products, including compliance with all laws, regulations and safety requirements or standards, regardless of any support or applications information provided by onsemi. "Typical" parameters which may be provided in onsemi data sheets and/or specifications can and do vary in different applications and actual performance may vary over time. All operating parameters, including "Typicals" must be validated for each customer application by customer's technical experts. onsemi does not convey any license under any of its intellectual property rights nor the rights of others. onsemi products are not designed, intended, or authorized for use as a critical component in life support systems or any EDA class 3 medical devices or medical devices with a same or similar classification in a foreign jurisdiction or any devices intended for implantation in the human

PUBLICATION ORDERING INFORMATION

LITERATURE FULFILLMENT: Email Requests to: orderlit@onsemi.com

onsemi Website: www.onsemi.com

TECHNICAL SUPPORT North American Technical Support: Voice Mail: 1 800-282-9855 Toll Free USA/Canada Phone: 011 421 33 790 2910

Europe, Middle East and Africa Technical Support:

Phone: 00421 33 790 2910

For additional information, please contact your local Sales Representative

单击下面可查看定价,库存,交付和生命周期等信息

>>ON Semiconductor(安森美)